

Search Notes

Application/Control No.

10/529,804

Examiner

Sikyin Ip

Applicant(s)/Patent under
Reexamination

OISHI, KEIICHIRO

Art Unit

1793

SEARCHED

Class	Subclass	Date	Examiner
148	433		
420	472		
	473		
	475	5/11/2008	SI

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN		
eDAN inventor name searched	5/11/2008	SI